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Search for associated Higgs boson production using like charge dilepton events in $p\bar{p}$ collisions at $\sqrt{s}= 1.96$ TeV

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Search for associated Higgs boson production using like charge dilepton events in $p\bar{p}$ collisions at $\sqrt{s} = 1.96$ TeV

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We present a search for associated Higgs boson production in the process $p\bar{p} \rightarrow W/ZH \rightarrow \ell^\pm \ell'^\pm + X$ in ee , $e\mu$, and $\mu\mu$ final states. The search is based on data collected by the D0 experiment at the Fermilab Tevatron Collider at $\sqrt{s} = 1.96$ TeV corresponding to 5.3 fb^{-1} of integrated luminosity. We require two isolated leptons (electrons or muons) with the same electric charge and additional kinematic requirements. No significant excess above background is observed, and we set 95% C.L. observed (expected) upper limits on ratio of the production cross section to the standard model prediction of 6.4 (7.3) for a Higgs boson mass of 165 GeV and 13.5 (19.8) for a mass of 115 GeV.

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I. INTRODUCTION

In the standard model (SM), the Higgs boson decays predominantly to a WW pair for Higgs boson masses above 135 GeV and, with a moderate branching fraction, to a $\tau\tau$ pair for lower masses, both of which decay to leptonic final

states involving neutrinos. Consequently the associated production of a Higgs boson, $p\bar{p} \rightarrow W/ZH \rightarrow \ell^\pm \ell'^\pm + X$, which has additional final state particles, provides easily-detected experimental signatures comprising two leptons of the same electric charge. This requirement rejects SM processes with oppositely charged dileptons that occur with high production rates such as Z/γ^* , WW , and $t\bar{t}$. Therefore, the like charge signature from associated vector boson-Higgs production has an advantage over direct Higgs production, $p\bar{p} \rightarrow H \rightarrow WW$, where only unlike charged leptons are produced in the final state.

The D0 Collaboration previously published a search for associated Higgs production with the like charge dilepton signature based on approximately 400 pb^{-1} of integrated luminosity in 2006 [1]. The most recent result from a similar search by the CDF experiment using 4.8 fb^{-1} of integrated luminosity [2] was included in the combination

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of Tevatron searches in the $H \rightarrow WW$ decay mode in 2010 [3].

In this Article, we present a search for associated Higgs boson production with like charged dileptons using 5.3 fb^{-1} of integrated luminosity collected by the D0 detector during the Tevatron Run II period between 2002 and 2009. The search combines the three leptonic final states with either electrons or muons: ee , $\mu\mu$, and $e\mu$.

Background processes for the like charge lepton signatures are diboson production, $p\bar{p} \rightarrow WZ \rightarrow \ell\nu\ell\ell$ and $p\bar{p} \rightarrow ZZ \rightarrow \ell\ell\ell\ell$. Nonresonant triple vector boson production (VVV , $V = W, Z$) and the production of $t\bar{t} + V$ are negligible. There are two types of instrumental backgrounds. The first, ‘‘charge flip’’, originates from the misreconstruction of the lepton charge. For the same lepton flavor channels (ee and $\mu\mu$) this background arises mainly from the Drell-Yan process, $p\bar{p} \rightarrow Z/\gamma^* \rightarrow \ell^+\ell^-$. When the two leptons are of different flavor, this background is negligible. The second instrumental background is from falsely identified leptons which originate from jets and photons converting to electrons in W boson or multijet production. Although these instrumental effects occur at low rate, the associated backgrounds make sizeable contributions to the dilepton selection due to the large production cross sections of the underlying physics processes.

The Higgs boson signal contains multiple neutrinos in the final state, hence a complete reconstruction of the Higgs boson mass is not possible. A Higgs boson signal would appear as an excess of events with like charged leptons with kinematic properties consistent with VH decay, including missing energy from the neutrinos in the leptonic decays of the vector bosons, as well as additional final state objects, mainly jets, from the decay of the third vector boson. A multivariate technique is employed to provide maximum separation between signal and background processes based on various kinematic variables. In the absence of an excess over the expected number of events from background processes, upper cross section limits are set.

II. EVENT SELECTION

Events are preselected by identifying at least two leptons. The selection of the electrons and muons include kinematic requirements as well as criteria on their quality. The final event selection is performed with a multivariate discriminant, which will be discussed later in this Article.

The D0 detector is composed of a central tracking system with a silicon microstrip tracker (SMT) and a central fiber tracker (CFT) embedded within a 2 T solenoidal magnet, preshower detectors, a uranium/liquid-argon calorimeter with electromagnetic (EM) and hadronic sections, and a muon spectrometer with drift tubes, scintillation counters, and toroidal magnets [4]. The detector was upgraded in spring 2006 to include, among others, an additional inner layer of silicon microstrip tracking [5].

A lepton is identified by the presence of a track, and its electrical charge is determined by the direction of the track curvature in the magnetic field. Events with like charged dileptons are retained for the analysis while those with unlike charged dileptons are used to validate the event reconstruction and simulation.

Electrons are characterized by their interaction in the EM calorimeter and are required to match a track. The energy is measured in the EM and the first hadronic layers of the calorimeter within a simple cone of radius $\mathcal{R} = \sqrt{(\Delta\eta)^2 + (\Delta\phi)^2} = 0.2$, where η and ϕ are the pseudorapidity [6] and the azimuthal angle, respectively. The electron cluster must satisfy calorimeter isolation fraction, $f_{\text{iso}} = [E_{\text{tot}}(\mathcal{R} < 0.4) - E_{\text{EM}}(\mathcal{R} < 0.2)]/E_{\text{EM}}(\mathcal{R} < 0.2)$, less than 0.2, where E_{tot} is the total energy in the isolation cone of radius $\mathcal{R} = 0.4$ and E_{EM} is the EM energy in a cone of radius $\mathcal{R} = 0.2$; EM fraction, $f_{\text{EM}} = E_{\text{EM}}/E_{\text{tot}}$, greater than 0.9, where both energies are measured within the cone of $\mathcal{R} = 0.2$; and the ratio of electron cluster energy to track momentum, E/p , between 0.5 and 3.0. In addition, the electron candidates are required to have an eight-variable likelihood (\mathcal{L}_e) greater than 0.85, where the likelihood is calculated from f_{iso} ; f_{EM} ; E/p ; number of tracks within the isolation cone; scalar sum of the tracks’ transverse momenta, p_T , within $0.05 < \mathcal{R} < 0.4$ of the electron track; track-cluster match probability computed from the spatial separation and the expected resolution; track distance to the primary vertex at closest approach (dca); and, lastly, covariance matrices built from the energy depositions in various layers of the calorimeter to represent the longitudinal and lateral shower development. A loose quality electron is defined by relaxing the requirement on the likelihood to $\mathcal{L}_e > 0.2$, and down to 0.01 or 0.0 depending on the purpose, and by removing the E/p requirement to estimate the lepton fake rate and model the backgrounds from W boson and multijet production.

Muons are identified by the presence of at least one track segment reconstructed in the muon spectrometer which is spatially consistent with a track in the central detector, where the momentum and charge are measured by the curvature of this track. The muon candidate must pass cosmic ray veto timing criteria, be outside a cone of radius $\mathcal{R} < 0.1$ from any jet of particles present in the event, and must not share its track with an electron candidate satisfying the calorimeter isolation and EM fraction requirements described above. Muon isolation is imposed with two isolation variables defined as the scalar sums of the transverse energy, ΣE_T^{calo} , in the calorimeter in an annulus with radius $0.1 < \mathcal{R} < 0.4$ and of the momenta of tracks, Σp_T^{trk} , around the muon candidate within a radius of $\mathcal{R} = 0.5$. Each of the two isolation variables must be less than 2.5 GeV. Relaxed isolation criteria define loose muon quality where the track isolation upper bound is raised to $\Sigma p_T^{\text{trk}} < 10$ GeV and the calorimeter isolation is ignored.

Both leptons are restricted to the central region within the CFT coverage, $|\eta_e| < 1.1$ for electrons and $|\eta_\mu| < 1.8$ for muons, and have transverse momenta in the range $15 \text{ GeV} < p_T < 200 \text{ GeV}$, together constraining the dilepton invariant mass to $15 \text{ GeV} < M(\ell, \ell) < 250 \text{ GeV}$. The upper thresholds were chosen to eliminate imprecise charge measurements in the tracking system. The signal loss due to the $|\eta|$ requirements is non-negligible; however, the reduction of instrumental backgrounds leads to an overall gain in the signal-to-background ratio. The two lepton tracks are required to have at least one hit in the SMT. The longitudinal (transverse) distance separating the point of closest approach between the tracks and the primary $p\bar{p}$ interaction vertex must be less than 1.0 (0.01) cm. The best interaction vertex, which is selected based on the number of associated tracks and their transverse momenta, must be within $|z| < 60 \text{ cm}$, where z is the longitudinal coordinate measured from the detector center. Additional leptons that satisfy the same lepton and track quality requirements are allowed up to $|\eta_e| < 2.5$ and $|\eta_\mu| < 2.0$. No upper p_T bound is imposed for these leptons.

The hadronic decays of vector bosons and partons are identified as jets of particles and are reconstructed by clustering the calorimeter energy deposition within a cone of radius $\mathcal{R} = 0.5$ [7]. Jets are required to have $p_T > 15 \text{ GeV}$ and $|\eta| < 2.5$. At least two tracks originating from the primary vertex must be found within the jet cone. Momentum imbalance in the transverse plane of the event implies the presence of the neutrino; the missing transverse energy, \cancel{E}_T , is reconstructed as the negative vector sum of the energies in the calorimeter towers and the muon momenta subtracting the calorimeter energy deposition due to muons.

III. EVENT SIMULATION

Associated production of the Higgs boson and the diboson background processes are modeled by Monte Carlo (MC) event generators and the detector response is provided by the GEANT based [8] simulation of the D0 detector. The effect of additional $p\bar{p}$ interactions is reproduced by overlaying data events taken from random collisions onto the MC generated processes. The signal and diboson processes are simulated by the PYTHIA event generator [9] using CTEQ6L1 [10] parton distribution functions (PDFs). The signal event samples are generated for different Higgs boson masses between 115 GeV and 200 GeV with 5 GeV intervals and normalized to the next-to-next-to-leading order (NNLO) cross sections calculated using MSTW2008 PDFs [11]. Branching ratios of Higgs boson decays are provided by HDECAY [12]. The diboson cross sections are calculated at next-to-leading order (NLO) using CTEQ6.1M PDFs [13], and the transverse momentum of the diboson system is reweighted to the prediction from MC@NLO [14]. Production of W bosons with additional emission of partons is simulated with the ALPGEN event

generator [15], which implements matrix element calculations, and the hadronization process is simulated by PYTHIA. The NNLO total cross sections calculated using MRST2004 PDFs [16] are used to normalize the sum of the W production processes with 0 through 5 associated light partons and the W production processes with heavy flavour quarks ($b\bar{b}$ or $c\bar{c}$).

The unlike charge dilepton events are used to study the event reconstruction and selection as well as instrumental effects. The events include physics processes which do not contribute to the like charge selection: Z/γ^* , $t\bar{t}$, and WW production. These processes are simulated using the PYTHIA generator, as described above. The Z/γ^* total cross sections are determined at NNLO, the WW cross section at NLO, and the $t\bar{t}$ cross section is obtained at approximate NNLO [17].

The overall normalization of the MC samples are initially obtained from the corresponding theoretical cross sections and the integrated luminosity recorded by the D0 detector. The kinematic dependences of the efficiencies of the triggers, lepton identification, and vertex selection as well as the mismodeling of instantaneous luminosity profile and beam spot position are corrected. Additional scale factors specific to this analysis are obtained by comparing the yields of the unlike charge dilepton events within the Z resonance in the dilepton invariant mass between 70 GeV and 110 GeV. The normalization factors include residual effects due to the efficiencies of triggers, lepton identification, track quality requirements, vertex selection, as well as the measurement of the integrated luminosity. The efficiencies specific to the electrons and the muons are measured with dielectron and dimuon events, respectively, while the effects that are common to the two lepton types have the same multiplicative contributions to the total normalization factors in both samples.

IV. INSTRUMENTAL BACKGROUNDS

The two largest instrumental backgrounds, charge mis-measurement and lepton misidentification, are estimated from data, either by measuring their rate using control samples enriched with the particular background processes or by performing a fit to the kinematic distribution to predict their fraction in the analysis sample. The separate contributions to the background from charge flip and W and multijet production are discussed below.

A. Charge flip

The charge flip background, created by mismeasurement of the charge of one of the leptons, mostly originates from the Z/γ^* process. This occurs when the curvature of a high p_T track is not correctly measured, or when additional hits from other charged particles and noise are present near the track. For electrons, conversion of photons from bremsstrahlung radiation is also estimated as part of the charge

flip background, although the charge may be correctly measured.

Contributions from charge flip in the $\mu\mu$ sample are estimated using two uncorrelated measurements of the lepton charge; the first one is the measurement of the track curvature in the central tracker, and the second measurement, called “local” muon charge, is measured by the muon spectrometer. The like charge dimuon samples are categorized into three types: events in which the two charge measurements give the same answer for both leptons (AA), agree for one lepton and disagree for another one (AD), or disagree for both leptons (DD). The number of events in these three categories depends on the actual number of like charge $\mu\mu$ events that originate from charge mismeasurements, N^{flip} , and those that originate from true like charge processes such as dibosons, N^{true} , as well as on the efficiency of the local charge measurement, ϵ_{loc} , which gives the probabilities of the AA/AD/DD configurations, P , for each case.

$$\begin{aligned} N_{AA} &= P_{AA}^{\text{true}}(\epsilon_{\text{loc}}) \cdot N^{\text{true}} + P_{AA}^{\text{flip}}(\epsilon_{\text{loc}}) \cdot N^{\text{flip}}, \\ N_{AD} &= P_{AD}^{\text{true}}(\epsilon_{\text{loc}}) \cdot N^{\text{true}} + P_{AD}^{\text{flip}}(\epsilon_{\text{loc}}) \cdot N^{\text{flip}}, \\ N_{DD} &= P_{DD}^{\text{true}}(\epsilon_{\text{loc}}) \cdot N^{\text{true}} + P_{DD}^{\text{flip}}(\epsilon_{\text{loc}}) \cdot N^{\text{flip}}. \end{aligned} \quad (1)$$

For a true like charge event to appear in the AA configuration, both leptons must have the correct local charge measurements, giving $P_{AA}^{\text{true}} = \epsilon_{\text{loc}} \cdot \epsilon_{\text{loc}}$. For a charge flip event where the central tracker mismeasures the charge of one lepton, the local charge must also be incorrect, hence $P_{AA}^{\text{flip}} = \epsilon_{\text{loc}}(1 - \epsilon_{\text{loc}})$. The parameterization of ϵ_{loc} is measured using unlike charge $Z \rightarrow \mu\mu$ events as a function of $1/p_T$ of the muon. The fraction of the charge flip events within the like charge $\mu\mu$ sample, $f^{\text{flip}} = N^{\text{flip}}/(N^{\text{flip}} + N^{\text{true}})$, is determined by solving the over-constrained equations yielding $f^{\text{flip}} = 0.95 \pm 0.14$ ¹. The ratio of the predicted number of charge flip events to the number of unlike charge events gives a charge mismeasurement rate in the dimuon sample of approximately 10^{-3} .

A different method is employed to estimate the charge flip contribution to the ee background, for which a second charge measurement does not exist. The charge flip event rate is measured with data using a control region enriched in $Z \rightarrow e^+e^-$ events, defined by a dielectron invariant mass reconstructed with precisely measured energies in the calorimeter, $85 \text{ GeV} < M(e, e) < 100 \text{ GeV}$ and an azimuthal separation between the leptons of $\Delta\phi(e, e) > 2.8$. The charge flip rate corresponds to the like charge fraction in the Z boson enriched region, removing contributions from known sources of true like charged dileptons such as diboson, W boson, and multijet production. The measured charge flip event rate in the control region in data after the dielectron selection is $(8.5 \pm 1.4) \times 10^{-4}$. The rate is then

used to scale the unlike charge distribution of the data outside the control region to obtain the charge flip prediction for the events selected for analysis.

The contribution of charge flips to the $e\mu$ selection is negligible as the dominant Z/γ^* production must decay via a τ lepton pair and is suppressed by the branching fraction of the τ lepton into an electron or a muon. In addition, leptons from τ decays have a lower p_T spectrum, hence the average charge flip rate is smaller.

The kinematic distributions of the charge flip events are modeled by unlike charge data, with corrections applied for the effects of charge mismeasurement derived using MC leptons. The corrections include the dependence of the charge flip rate on the lepton p_T and η in the detector and the resolution of the muon momentum measured from the track curvature, parameterized as a function of $1/p_T$.

B. W Production

The production of W bosons contributes to the like charge dilepton background when there is a “fake” lepton which can originate from jets or when there are photon conversions to electrons. The contribution from these backgrounds is estimated using MC simulations, taking into account corrections derived from data for the electron misidentification rate and photon conversions.

The corrections to these two subcategories in the MC samples are obtained in two steps using template fits to the kinematic distributions in a W boson enriched region in the ee sample, which requires one of the electrons to have loose quality, defined by the \mathcal{L}_e variable, and to fail the tight selection used for the analysis. The first step determines the normalization of the W boson background as well as the charge flip and multijet contributions in the control region using a two-dimensional distribution defined by $M(e, e)$ and \cancel{E}_T . The second step determines the fractions of the two contributions within the W boson sample, jets and photons, while keeping the overall normalization of the total sum derived in the first step. The presence of a hit in the first layer of the SMT detector is used to discriminate between the two contributions; the photon conversion rate scales as the amount of material the photon traverses; hence a sizeable fraction of electrons from photon conversion are expected to have no hit in the first SMT layer. To increase the purity of the W process in the control sample, we require $\cancel{E}_T > 25 \text{ GeV}$ and $M_T(e, \cancel{E}_T) > 40 \text{ GeV}$, where $M_T(e, \cancel{E}_T) = \sqrt{2 \cdot p_{Te} \cdot \cancel{E}_T (1 - \cos\Delta\phi)}$, where $\Delta\phi$ is the angle in the azimuthal plane between the electron and the direction of \cancel{E}_T , and e is the electron which gives the maximum value of M_T . The requirement on the electron likelihood is relaxed to a minimal value of $\mathcal{L}_e > 0$ for the first step to maximize the number of W boson events in the control region and raised to 0.01 for the second stage to increase the W boson + photon fraction. The normalization factor obtained in the first stage is 1.2, and the correction factors for

¹The positive uncertainty is constrained by the total background yield at later stage to obtain the final result.

$W + \text{jet}$ and $W + \text{photon}$ contributions obtained in the second step are 0.95 and 1.01, respectively. The total systematic uncertainty on the W boson background prediction is discussed later.

The efficiency for a jet identified as a loose electron, to pass as a tight electron, is determined from a dedicated dijet data sample where one of the jets is identified as a loose quality electron candidate. The events are required to contain only one lepton candidate, back-to-back with a jet, $\Delta\phi(e, \text{jet}) > 2.5$, have low transverse mass, $M_T(e, \cancel{E}_T) < 40$ GeV, and invariant mass with any track lower than the Z resonance, $M(e, \text{trk}) < 60$ GeV, to suppress contamination from true electrons in W/Z decays. Additional physics contamination is estimated by comparing the shape of the \mathcal{L}_e variable for the electron candidates in the fake data sample to that in MC dijet events. The measured fake rate, parameterized in p_T and η , is then used to scale the $W + \text{jet}$ MC sample selected with the tight-loose requirement to the tight-tight region. No additional correction is made to the $W + \text{photon}$ content of the MC sample as the electrons from photon conversions are correctly modeled by the simulation.

C. Multijet

In the case of jets misidentified as muons, the multijet background contains muons from semileptonic decays of heavy flavor quarks, punch-through hadrons in the muon detector, and muons from pion or kaon decays in flight. In the case of jets misidentified as electrons, the multijet background contains electrons from semileptonic heavy flavor decays, from hadrons misidentified as electrons, and from photon conversions.

Multijet contributions to the ee and $\mu\mu$ samples are estimated from data events in a control sample containing two loose quality like charged leptons using the loose-to-tight efficiency of fake leptons, ε_F , as measured in that sample. Within a sample of pure multijet events, the fraction of events with no tight lepton (f_0) and with exactly one tight lepton (f_1) is

$$\begin{aligned} f_0 &= (1 - \varepsilon_F)[1 - \varepsilon_F(1 - \rho)], \\ f_1 &= 2(1 - \varepsilon_F)\varepsilon_F(1 - \rho), \end{aligned} \quad (2)$$

where ρ is the correlation coefficient, reflecting that the identification of a lepton may be different in events where another lepton has been already identified. These equations are solved for ε_F and ρ . Then the fraction of multijet events with two leptons passing the tight selection criteria is given by

$$f_2 = \varepsilon_F^2(1 - \rho) + \rho\varepsilon_F. \quad (3)$$

The control region is $30 \text{ GeV} < M(\ell, \ell) < 50 \text{ GeV}$ and $\Delta\phi(\ell, \ell) > 2.5$, where $\Delta\phi(\ell, \ell)$ is the azimuthal angle between the two leptons. The correlation coefficient is 0.01 ± 0.05 for the ee channel and 0.18 ± 0.06 for the

$\mu\mu$ channel. The efficiencies are 0.169 ± 0.014 and 0.091 ± 0.009 for the ee and the $\mu\mu$ channels, respectively. Examination of the variation of ε_F and ρ as track quality requirements are removed shows no sign of charge flip contamination in the control region, and the spectrum of $M_T(\ell, E_T)$ shows no sign of W boson contamination. Our ability to identify contaminations from other background processes (in particular events with charge flips) is limited by the statistics of the data sample in the control region. As such contaminants would raise the background estimate, we add a one-sided uncertainty in quadrature on the low side of the estimate, in amount equal to the statistical uncertainty in the estimate.

The number of multijet events in the $e\mu$ selection is estimated by performing a fit of the \mathcal{L}_e distribution to templates of true and fake electrons taken from data. While the \mathcal{L}_e requirement must be relaxed for this fit, tight E/p requirements for the electrons and tight muon selection requirements are retained. The template distribution for true electrons is obtained from the ee pairs at the Z resonance. The template distribution for fake electrons is obtained from like charge data events in a similar control region as is used in the ee and $\mu\mu$ case. The method estimates all contributions from processes containing fake electrons, including $W + \text{jet}$ production; hence the corresponding process is removed from the W MC sample.

The shapes of the kinematic distributions for multijet backgrounds are modeled by events in like charge data with loose lepton quality but failing the tight criteria. The electron requirement is relaxed to $\mathcal{L}_e > 0$ to obtain a sufficient number of events. The lepton quality requirements are inverted for both leptons in ee and $\mu\mu$ channels. For the $e\mu$ channel, events with a tight muon are also used to model the $W + \text{jet}$ contribution included in the multijet rate prediction. The kinematic dependence due to the inversion of lepton qualities is corrected using the loose-to-tight efficiency for fake leptons obtained in the dijet sample and by the method described in the section for W boson background. For the $\mu\mu$ selection, the multijet background mostly comes from the semileptonic decays of heavy flavor quark decays; hence the correction derived from the dijet sample is not used for the $\mu\mu$ channel.

V. MULTIVARIATE ANALYSIS

A multivariate technique is employed to characterize the Higgs boson signal and the backgrounds and to achieve maximum separation between them. A Boosted-Decision-Tree (BDT) algorithm [18] is used to construct a discriminant from kinematic variables taking into account the variable correlations. The algorithm is robust against low number of events, which is particularly beneficial for the like charged dilepton search where the data samples used to model the instrumental backgrounds are limited.

The kinematic variables considered for the BDT inputs are:

- (i) Dilepton kinematics: leading and trailing lepton transverse momenta [$p_T^{\ell 1}$, $p_T^{\ell 2}$], invariant mass [$M(\ell, \ell)$], angular separation [$\Delta\eta(\ell, \ell)$, $\Delta\phi(\ell, \ell)$, $\Delta R(\ell, \ell)$];
- (ii) Kinematics of all leptons in the event: lepton multiplicity [N^ℓ], vector sum and scalar sum of p_T of all leptons [$p_T^{\Sigma\ell}$, Σp_T^ℓ];
- (iii) Kinematics of all jets in the event: jet multiplicity [N^{jet}], vector sum and scalar sum of p_T of all jets [H_T , Σp_T^{jet}];
- (iv) Kinematics of all the objects (leptons and jets) in the event: object multiplicity [N^{obj}], vector and scalar sum of p_T of all objects [$p_T^{\Sigma\text{obj}}$, Σp_T^{obj}];
- (v) Missing transverse energy: missing transverse energy [\cancel{E}_T], component perpendicular to the object/muon which is closest to the \cancel{E}_T axis in ϕ [$\cancel{E}_T^{\text{spec}/\mu}$] to be insensitive to a possible mismeasurement of the object momentum;
- (vi) Dilepton- \cancel{E}_T relation: transverse mass with minimum/maximum value [$M_T(\ell, \cancel{E}_T)^{\text{min}/\text{max}}$] (those

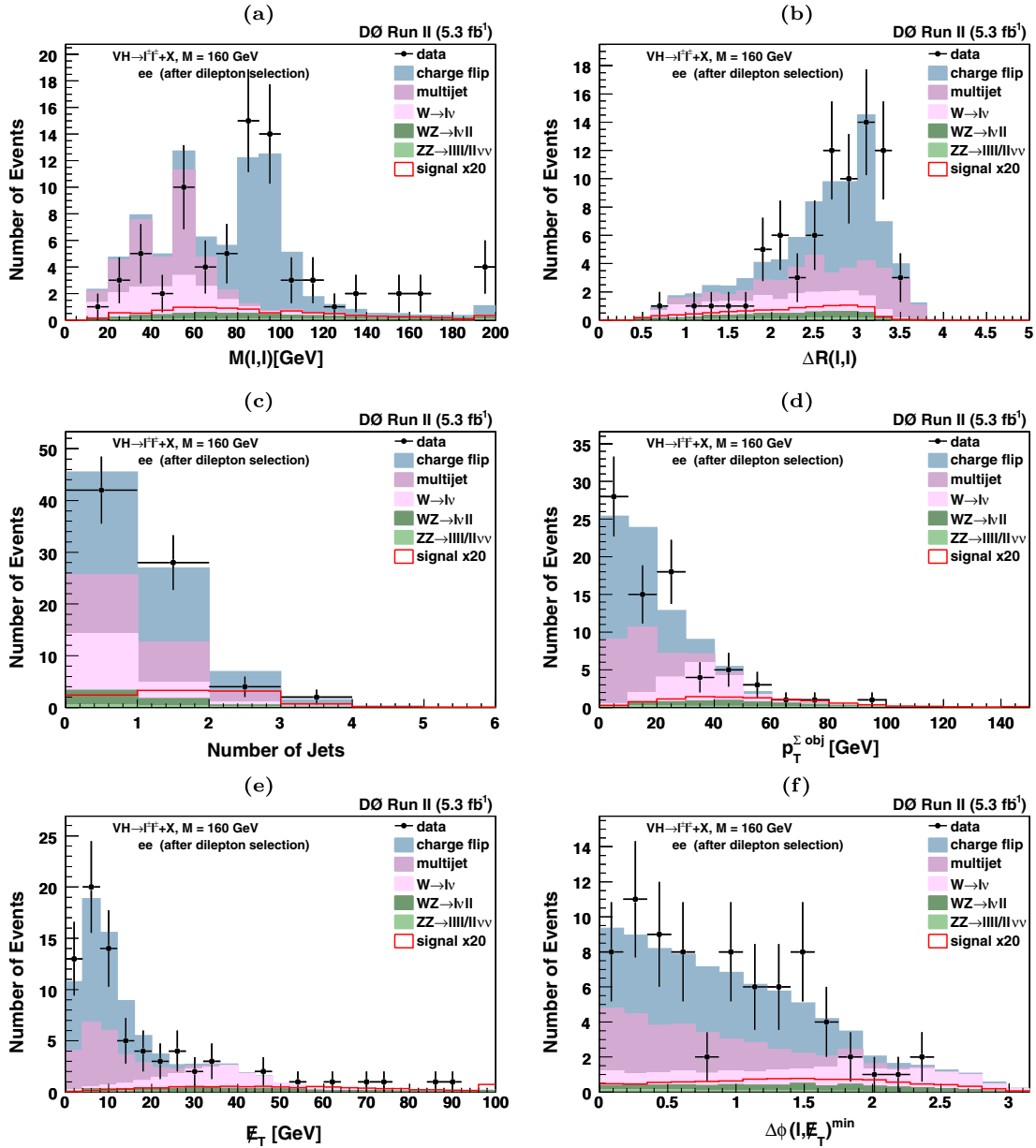


FIG. 1 (color online). The distribution of (a) $M(\ell, \ell)$, (b) $\Delta R(\ell, \ell)$, (c) N_{jet} , (d) $p_T^{\Sigma\text{obj}}$, (e) \cancel{E}_T , (f) $\Delta\phi(\ell, \cancel{E}_T)^{\text{min}}$ for the ee channel comparing data and predicted backgrounds as well as the Higgs boson signal ($M_H = 160$ GeV) expectation after the kinematic selection of like charge dilepton events.

calculated with respect to electron/muon for $e\mu$ channel only [$M_T(e/\mu, \cancel{E}_T)$], minimum/maximum azimuthal angular separation [$\Delta\phi(\ell, \cancel{E}_T)^{\min/\max}$].

Between 11 and 17 variables are selected from this list for the training of BDTs based on the discrimination power of the variables for a given channel. Distributions of representative variables are shown in Figs. 1–3 for ee , $\mu\mu$, and $e\mu$ channels after kinematic selection of like charge dilepton events.

The BDT is trained for each Higgs boson mass considered. The Higgs signal and background model samples

described in the previous sections are separated into two orthogonal samples such that there is no overlap between events used for training and those used to derive the final result of the search. The training is carried out in two stages. The first stage uses one or two specific background processes that are dominant after the kinematic selection, charge flip and multijet for ee and $\mu\mu$, multijet and $W + \text{jet}$ for the $e\mu$ channel. The resulting instrumental BDT discriminant, BDT_i , is used to separate signal-like and backgroundlike events [Fig. 4(a), 4(c), and 4(e)]. The second stage of training, referred to as “physics BDT,” uses those events that appear in the signal-like region of

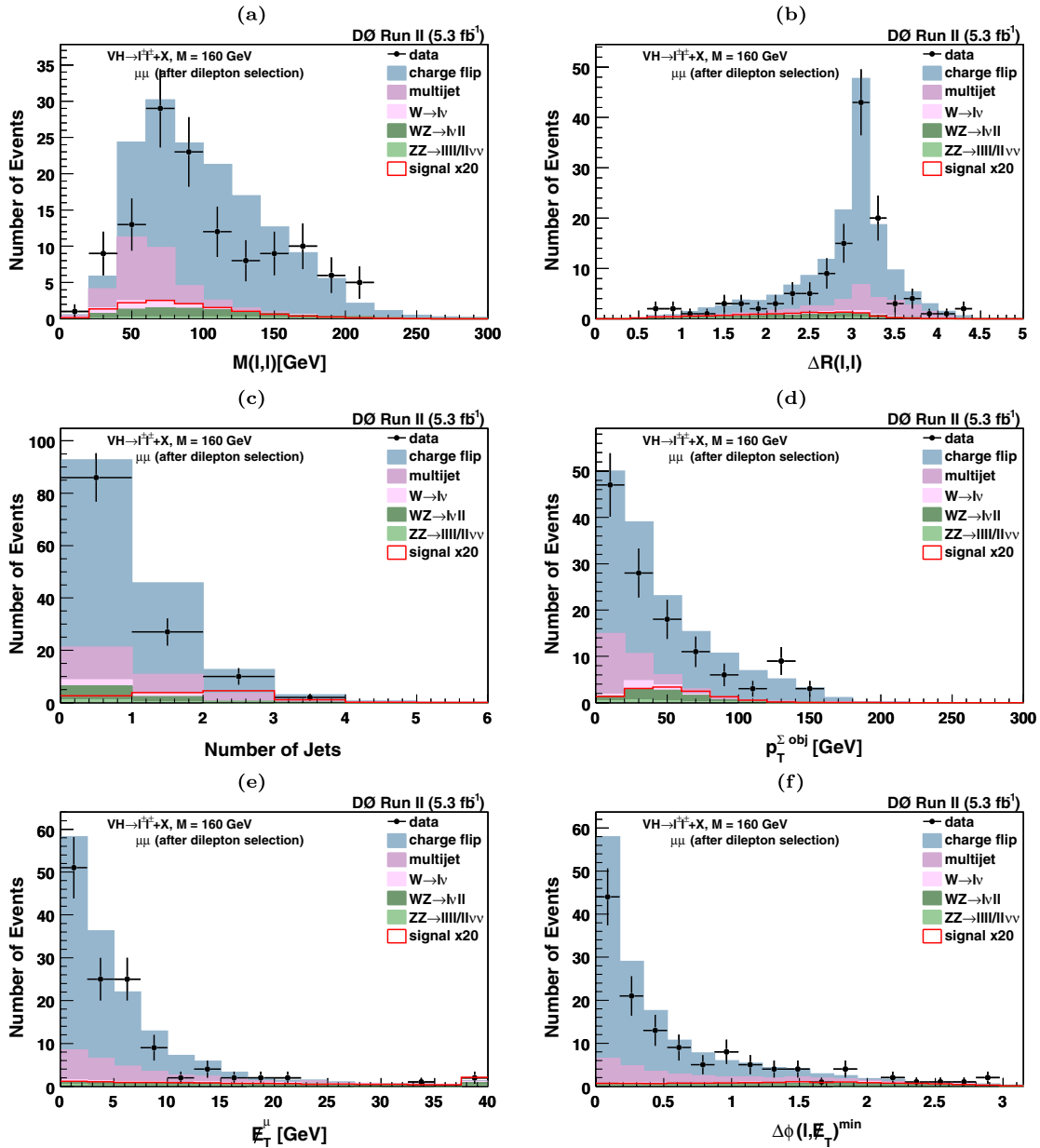


FIG. 2 (color online). The distribution of (a) $M(\ell, \ell)$, (b) $\Delta R(\ell, \ell)$, (c) N_{jet} , (d) $p_T^{\Sigma \text{obj}}$, (e) \cancel{E}_T^μ , (f) $\Delta\phi(\ell, \cancel{E}_T^\mu)^{\min}$ for the $\mu\mu$ channel comparing data and predicted backgrounds as well as the Higgs boson signal ($M_H = 160$ GeV) expectation after the kinematic selection of like charge dilepton events.

BDT_{*i*}, where the threshold is optimized for a signal efficiency of approximately 90% for each mass point. The combined background samples are used for *ee* and $\mu\mu$ training, which are mostly diboson and *W* boson or charge flip processes, and diboson only for *eμ*. All variables from the list that have discrimination power and are well modeled by the prediction are selected for each stage of the training and for each of the three channels. The input variables used for the physics BDT training for *ee* and

$\mu\mu$ channels are $p_T^{\ell 1}$, $p_T^{\ell 2}$, $\Delta\eta(\ell, \ell)$, $M(\ell, \ell)$, $p_T^{\Sigma\ell}$, Σp_T^{ℓ} , \cancel{E}_T , $\cancel{E}_T^{\text{spec}}$, $M_T(\ell, \cancel{E}_T)^{\text{min}}$, $\Delta\phi(\ell, \cancel{E}_T)^{\text{min/max}}$. The input variables used for the physics BDT training for *eμ* channel are $p_T^{\ell 1}$, $p_T^{\ell 2}$, $\Delta\eta(\ell, \ell)$, $\Delta\phi(\ell, \ell)$, $\Delta R(\ell, \ell)$, $M(\ell, \ell)$, $p_T^{\Sigma\ell}$, H_T , Σp_T^{jet} , $p_T^{\Sigma\text{obj}}$, Σp_T^{obj} , \cancel{E}_T , $\cancel{E}_T^{\text{spec}}$, $M_T(\ell, \cancel{E}_T)^{\text{min/max}}$, $\Delta\phi(\ell, \cancel{E}_T)^{\text{min/max}}$, BDT_{*i*}. The final discriminant for each channel is computed as an effective product of the two discriminants after the selection based on BDT_{*i*} (Fig. 4).

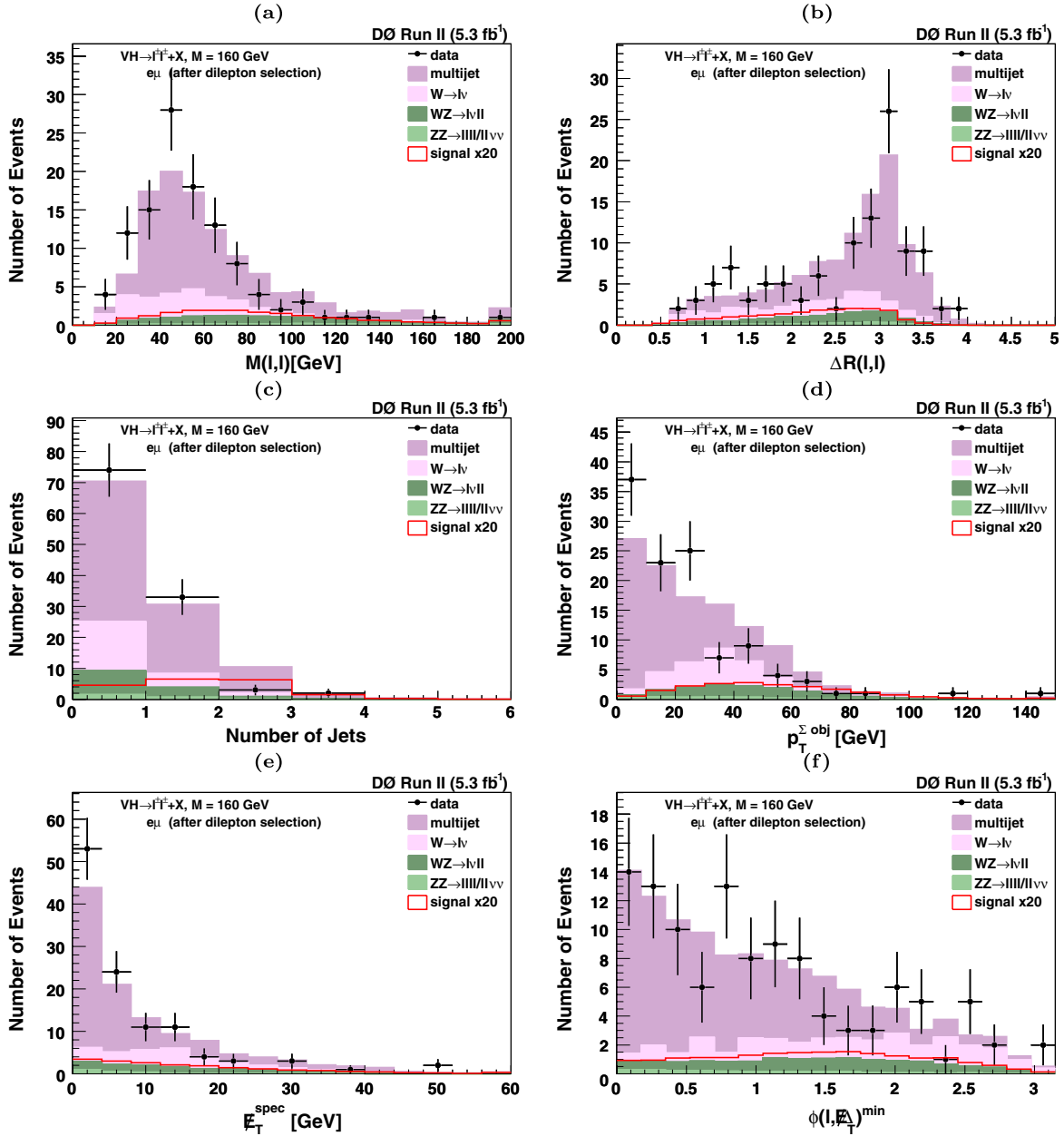


FIG. 3 (color online). The distribution of (a) $M(\ell, \ell)$, (b) $\Delta R(\ell, \ell)$, (c) N_{jet} , (d) $p_T^{\Sigma\text{obj}}$, (e) $\cancel{E}_T^{\text{spec}}$, (f) $\Delta\phi(\ell, \cancel{E}_T)^{\text{min}}$ for the *eμ* channel comparing data and predicted backgrounds as well as the Higgs boson signal ($M_H = 160$ GeV) expectation after the kinematic selection of like charge dilepton events. Because of the absence of charge flip background in *eμ* channel, the sample after kinematic selection is dominated by multijet and *W* + jet backgrounds.

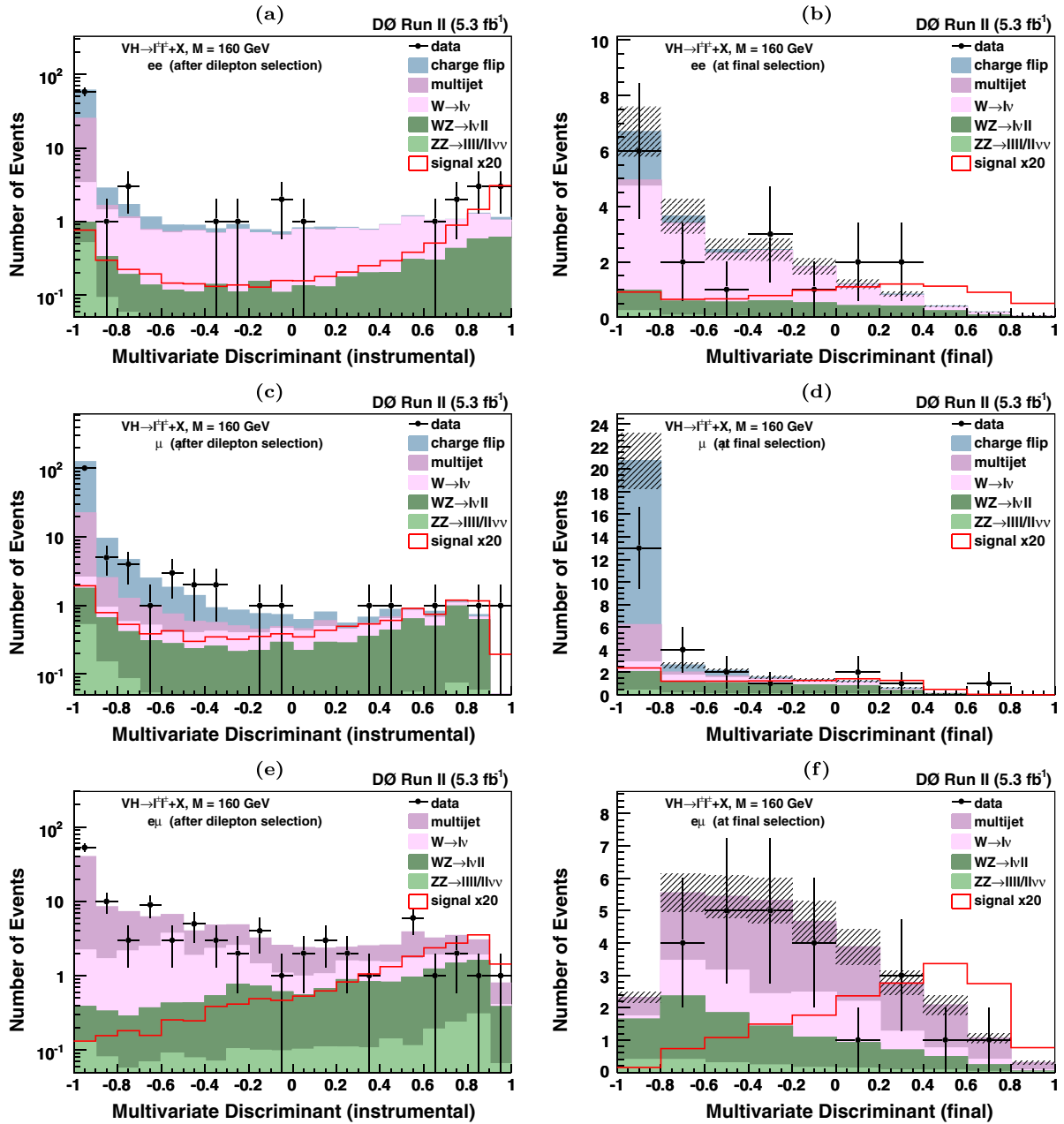


FIG. 4 (color online). The distribution of [(a), (c), (e)] the multivariate discriminant against instrumental backgrounds, BDT_i , and [(b), (d), (f)] the final discriminant which is an effective product of the BDT outputs from the first stage (instrumental) and the second stage (physics) for the [(a), (b)] ee [(c), (d)] $\mu\mu$ and [(e), (f)] $e\mu$ channels. Data and background predictions corresponding to an integrated luminosity of 5.3 fb^{-1} and the signal distributions are shown for an assumed Higgs boson mass of 160 GeV . The shaded region represents the total uncertainty on the background prediction. The final discriminant distributions are shown after requirements on $BDT_i > -0.85, -0.9, -0.2$ for the $ee, \mu\mu, e\mu$ channels, respectively, corresponding to approximately 90% signal efficiency points for a Higgs boson mass of 160 GeV .

VI. CROSS SECTION LIMITS

The final multivariate discriminants after all selection criteria [Fig. 4(b), 4(d), and 4(f)] show that the data are well described by the sum of the background predictions. In absence of an excess in the number of observed events over the SM backgrounds, upper limits on the production cross section have been determined.

Uncertainties on the SM cross section for the processes modeled by MC simulation are 5% for the associated Higgs boson production, 7% for diboson (WZ/ZZ) production, and 6% for W boson production. Experimental uncertainties assigned to the MC include a normalization uncertainty of 4.7%, which enfolds the lepton trigger and identification efficiencies and their kinematic dependences

TABLE I. The number of predicted and observed events for 5.3 fb^{-1} of Run II integrated luminosity, after kinematic selection of like charged dileptons and after the final selection based on the multivariate discriminant against instrumental background, BDT_i . This excludes the two control regions used for the estimation of the charge flip and multijet backgrounds. The uncertainties reflect the total systematic uncertainties.

	Kinematic selection			Kinematic + BDT_i selection		
	ee	$\mu\mu$	$e\mu$	ee	$\mu\mu$	$e\mu$
$WZ \rightarrow \ell\nu\ell\ell$	4.46 ± 0.39	7.56 ± 0.66	11.81 ± 1.03	3.89 ± 0.34	6.32 ± 0.55	8.98 ± 0.78
$ZZ \rightarrow \ell\ell\ell\ell$	0.92 ± 0.08	1.38 ± 0.12	2.34 ± 0.20	0.35 ± 0.03	0.86 ± 0.08	1.66 ± 0.14
$W \rightarrow \ell\nu$	14.8 ± 3.3	3.9 ± 0.8	21.4 ± 6.7	12.8 ± 2.9	3.0 ± 0.6	7.2 ± 2.3
Multijet	22.0 ± 7.5	23.5 ± 7.6	78.6 ± 16.7	0.3 ± 0.1	3.9 ± 1.3	15.5 ± 3.3
Charge flip	39.0 ± 6.9	118.4 ± 17.0	— — —	2.4 ± 0.4	16.2 ± 2.5	— — —
Total background	81.2 ± 10.7	154.7 ± 18.7	114.2 ± 18.1	19.7 ± 2.9	30.3 ± 2.9	33.4 ± 4.1
Data	76	125	112	17	24	24
$VH (M_H = 120 \text{ GeV})$	0.29 ± 0.02	0.44 ± 0.03	0.73 ± 0.05	0.26 ± 0.02	0.35 ± 0.03	0.65 ± 0.05
$VH (M_H = 160 \text{ GeV})$	0.49 ± 0.03	0.62 ± 0.04	0.96 ± 0.07	0.44 ± 0.03	0.52 ± 0.04	0.86 ± 0.06
$VH (M_H = 200 \text{ GeV})$	0.21 ± 0.01	0.27 ± 0.02	0.47 ± 0.03	0.19 ± 0.01	0.24 ± 0.02	0.42 ± 0.03

and the uncertainty of the Z boson production cross section used to study the normalization, and a 2% uncertainty on mismodeling of jets. An additional uncertainty is assigned to the W boson background based on studies using the control samples; 20% uncertainty is used for each misidentified muon, 50%/14% for each misidentified electron originating from a photon/jet. The instrumental backgrounds, charge flip and multijet, which are estimated directly from data, have uncertainties between 11%–42%, arising mainly from the limited number of events in the control samples and the extrapolation to the signal search region. The mismodeling of the kinematics of the instrumental backgrounds are represented by a difference in the shape of the multivariate discriminants and corresponds to up to 20% uncertainty on the final yield. The uncertainties described above are considered uncorrelated.

The number of predicted and observed events after the kinematic selection of two like charged leptons and after

the additional selection based on the multivariate discriminant BDT_i are listed in Table I. The total uncertainties associated with each background and signal processes, excluding the shape uncertainty for the instrumental backgrounds, are given.

Cross section upper limits have been determined with the modified frequentist approach [19] with a log-likelihood ratio (LLR) test statistics. The systematic uncertainty of the signal and background predictions are represented by a Gaussian distributed fluctuation of the expected yield, where correlations across different channels for any particular uncertainty are taken into account. The details of the calculation are explained in Ref. [20]. Upper limits on the W/ZH cross section expressed as a ratio to the SM Higgs cross section and the corresponding LLR distributions are shown in Fig. 5. Ratio limits for each dilepton channel and for the combination are summarized in Table II.

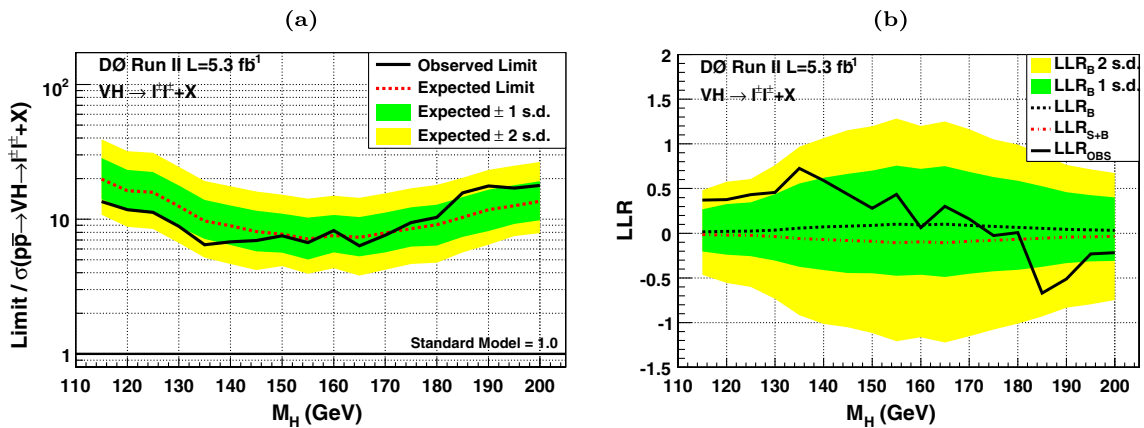


FIG. 5 (color online). (a) the expected and observed production cross section limits in terms of the ratio to the SM cross section as a function of the Higgs boson mass for an integrated luminosity of 5.3 fb^{-1} combining ee , $\mu\mu$, and $e\mu$ channels. (b) the corresponding LLR distribution.

TABLE II. The expected and observed production cross section limits in terms of ratios to the SM cross section for individual channels and for the combination.

		D0 Run II Limits for $W/ZH \rightarrow \ell^\pm \ell'^\pm + X$ (5.3 fb^{-1})																	
m_H		115	120	125	130	135	140	145	150	155	160	165	170	175	180	185	190	195	200
ee	exp	44.6	38.4	30.6	25.4	22.3	19.1	18.2	17.4	15.9	16.3	16.9	17.8	18.8	20.1	22.6	25.6	27.7	29.7
	obs	27.0	29.8	21.9	20.3	18.2	17.9	19.5	22.6	16.9	17.1	18.8	20.8	26.8	26.6	34.9	45.3	39.7	40.4
$\mu\mu$	exp	37.6	30.0	33.5	22.8	20.2	18.2	17.8	17.3	16.7	17.0	17.6	20.1	20.9	23.0	26.0	30.0	33.2	34.5
	obs	34.0	25.3	30.4	23.9	19.6	18.2	19.1	18.7	20.4	22.0	19.4	23.3	25.4	24.8	35.1	40.2	39.7	37.6
$e\mu$	exp	27.7	23.0	23.3	20.3	13.9	13.4	11.6	10.9	10.3	11.5	10.5	11.3	12.7	13.2	15.0	17.2	18.5	19.6
	obs	21.9	17.2	17.8	12.6	8.7	9.0	8.1	8.0	7.3	9.6	7.1	8.0	9.1	11.7	14.8	15.6	19.3	22.0
All	exp	19.8	16.2	15.8	12.5	9.7	8.9	8.1	7.7	7.1	7.6	7.3	7.9	8.5	9.1	10.3	11.7	12.6	13.6
	obs	13.5	11.8	11.2	8.8	6.4	6.8	7.0	7.5	6.7	8.2	6.4	7.6	9.4	10.3	15.7	17.7	17.0	17.8

VII. CONCLUSIONS

A search for associated production of SM Higgs boson, $p\bar{p} \rightarrow W/ZH$, has been performed with a final state with two like charged leptons, $W/ZH \rightarrow \ell^\pm \ell'^\pm + X$, in the ee , $e\mu$, and $\mu\mu$ channels. After all selection criteria, 17 events in the ee channel, 24 events in the $e\mu$ channel, and 24 events in the $\mu\mu$ channel have been observed in agreement with SM predictions. The observed (expected) upper limits on $\sigma(W/ZH) \times \mathcal{B}(W/ZH \rightarrow \ell^\pm \ell'^\pm + X)$ for all three channels combined using a total integrated luminosity of 5.3 fb^{-1} collected by the D0 detector in $p\bar{p}$ collisions at $\sqrt{s} = 1.96 \text{ TeV}$, expressed as a ratio to the SM Higgs cross section, are found to be 6.4 (7.3) for a Higgs boson mass of 165 GeV and 13.5 (19.8) for 115 GeV.

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